

Notice of References Cited	Application/Control No. 10/660,055	Applicant(s)/Patent Under Reexamination KNEE ET AL.	
	Examiner Sargon N. Nano	Art Unit 2157	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0016843	02-2002	Schweitzer et al.	709/227
*	C	US-2003/0177252	09-2003	Krichevski et al.	709/230
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*	E	US-7,257,817	08-2007	Cabrera et al.	719/310
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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